



# Electromagnetic Compatibility Test Summary and Report

EMC Quote #	2014-035	Testing Started	1/29/144	Date parts received	1/29/14
Test Plan/ Request ID/ Approval #	None	Testing Completed	1/30/14	Functional Class	TBD
Applicable Specification	CISPR 25: (2008) ISO 11452-4 (2005)			Product Phase	ED - Engineering Development
Device Under Test (DUT) Description	Serializer & Deserializer				
Testing Requested by	Texas Instruments 2900 Semiconductor Drive Santa Clara, CA 95051	ID/Serial #s	DS90UH927	Serializer	
			DS90UH928	Deserializer	
		Model #	Serializer/Deserializer		

## Summary of Testing:




CISPR 25: (2008)	Performance Deviations?		Compliant With Specification / Test Plan?		
	NO	YES	NO	YES	TBD by Customer
6.3 Conducted Emissions - Current Probe Method	X			X	
6.4 Radiated Emissions - ALSE Method	X			X	

TBD = To Be Determined

## Summary of Testing:

ISO 11452-4 (2005)	Performance Deviations?		Compliant With Specification / Test Plan?		
	NO	YES	NO	YES	TBD by Customer
11452-4 Bulk Current Injection	X			X	

TBD = To Be Determined

Date:	This report was prepared by:	This report was reviewed by:
February 3, 2014		
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The test results contained in this report relate only to the specific devices listed above.

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All measurement instrumentation is traceable to the National Institute of Standards and Technology (NIST).



**Test Method Name:** 6.3 Conducted Emissions - Current Probe Method

**Report Author:** Jason Harris - WiSE Laboratory Technician

**Test Setup Comments:** Testing was performed in accordance with the applicable specification and customer Instruction (no customer test plan).

**DUT Disposition:** Devices were retained in the UL EMC Lab for subsequent testing.

**Summary of Results:** No peaks over specification limits.



<b>Company Name:</b>	Texas Instruments	<b>Test Name:</b>	6.3 Conducted Emissions - Current Probe Method
<b>Harness Information:</b>	2.0 m	<b>Date(s) test performed:</b>	1/30/2014
<b>Grounding Information:</b>	Remote Ground	<b>Temperature (°C):</b>	20
<b>Pretest inspection:</b>	<input checked="" type="checkbox"/> No anomalies <input type="checkbox"/> The following anomalies:	<b>Humidity (%RH):</b>	9
<b>Posttest inspection:</b>	<input checked="" type="checkbox"/> No anomalies <input type="checkbox"/> The following anomalies:	<b>Tested by:</b>	Jason Harris
<b>Sample #</b>	DS90UH927		
<b>Mode:</b>	ON		
<b>Ambient Compliant:</b>	<input type="checkbox"/> No <input checked="" type="checkbox"/> Yes		
<b>Probe Position</b>	<b>Comments</b>	<b>Over/Under Limit</b>	
50mm	(SER)	<input type="checkbox"/> Over <input checked="" type="checkbox"/> Under	
750mm	(SER)	<input type="checkbox"/> Over <input checked="" type="checkbox"/> Under	

<b>Company Name:</b>	Texas Instruments	<b>Test Name:</b>	6.3 Conducted Emissions - Current Probe Method
<b>Harness Information:</b>	2.0 m	<b>Date(s) test performed:</b>	1/30/2014
<b>Grounding Information:</b>	Remote Ground	<b>Temperature (°C):</b>	20
<b>Pretest inspection:</b>	<input checked="" type="checkbox"/> No anomalies <input type="checkbox"/> The following anomalies:	<b>Humidity (%RH):</b>	9
<b>Posttest inspection:</b>	<input checked="" type="checkbox"/> No anomalies <input type="checkbox"/> The following anomalies:	<b>Tested by:</b>	Jason Harris
<b>Sample #</b>	DS90UH9278		
<b>Mode:</b>	ON		
<b>Ambient Compliant:</b>	<input type="checkbox"/> No <input checked="" type="checkbox"/> Yes		
<b>Probe Position</b>	<b>Comments</b>	<b>Over/Under Limit</b>	
50mm	(DES)	<input type="checkbox"/> Over <input checked="" type="checkbox"/> Under	
750mm	(DES)	<input type="checkbox"/> Over <input checked="" type="checkbox"/> Under	

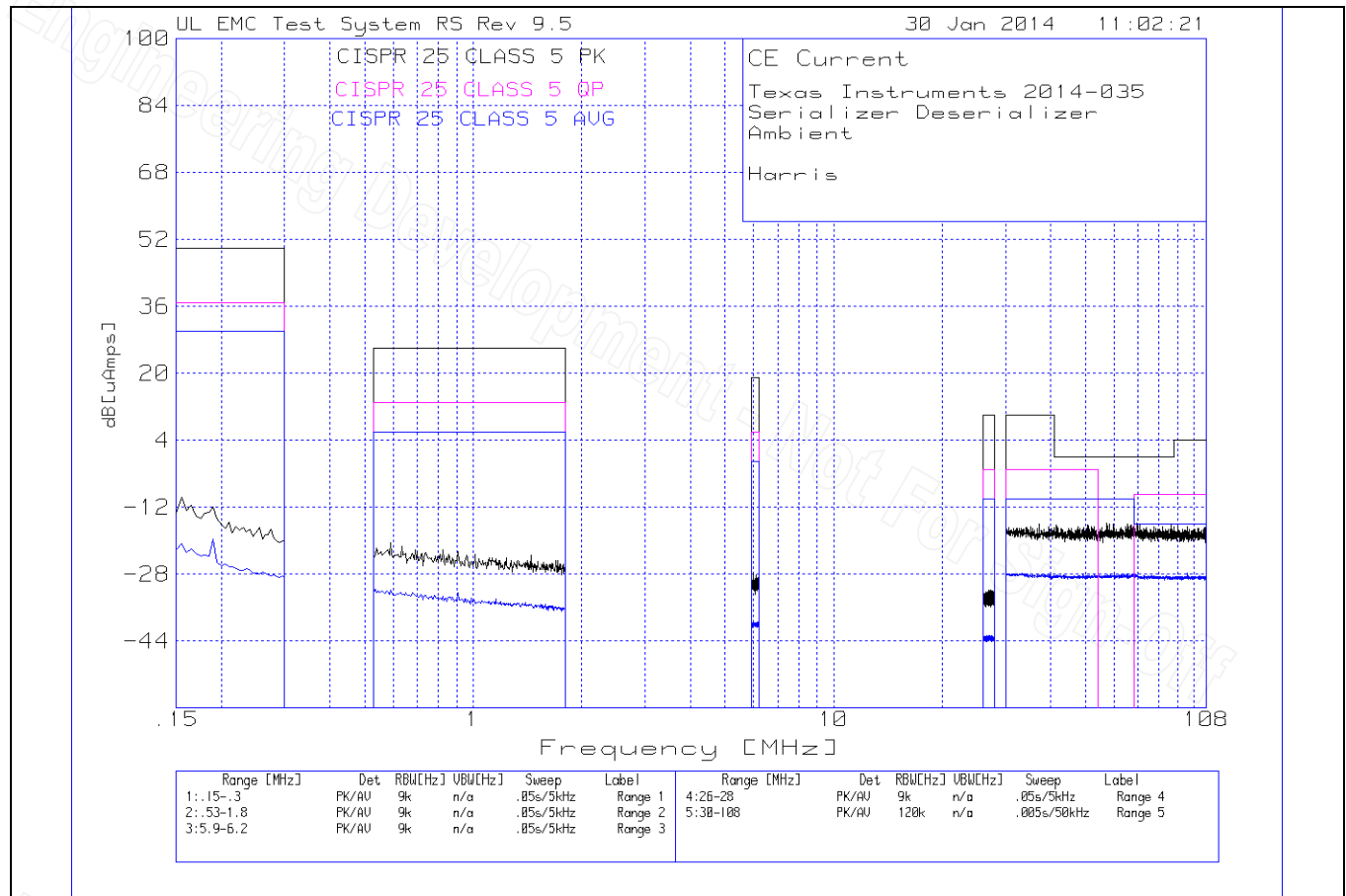


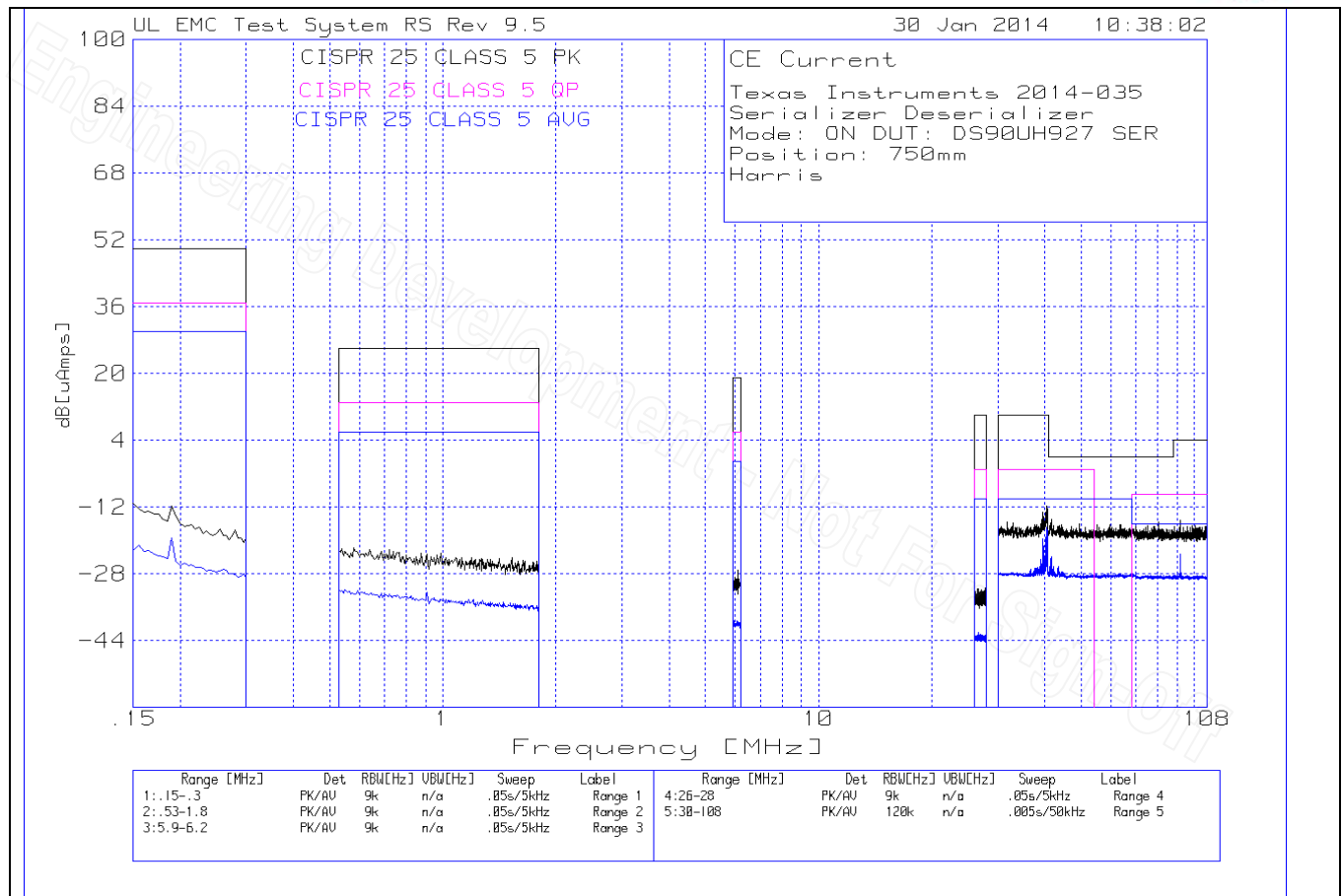
#### UL Provided Test Equipment

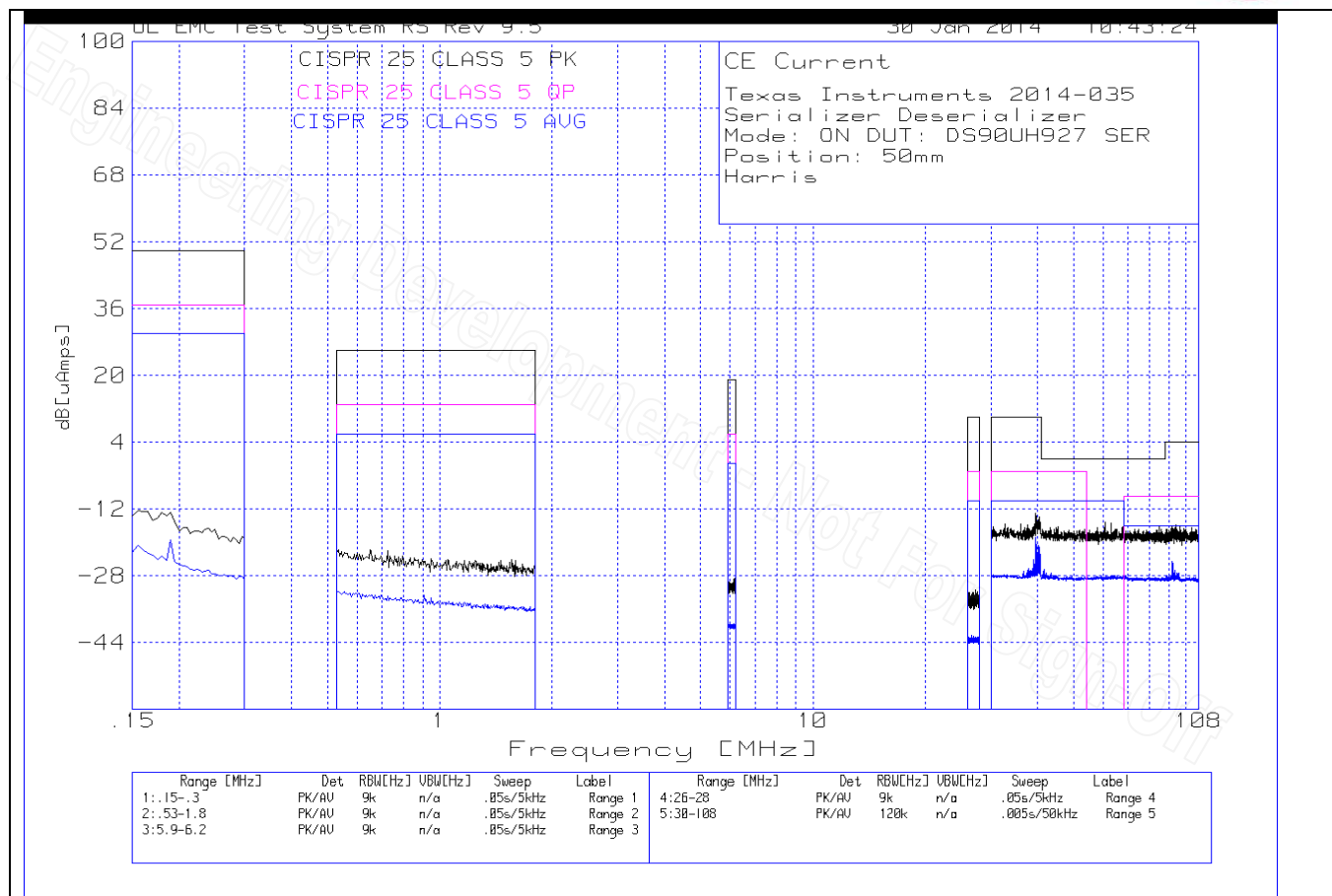
Asset #	Manufacturer / Model #	Description	Cal. Due
ATA804	ETS Lindgren (-)	Chamber	1/31/15
SA0014	Rohde & Schwarz (ESCI7)	Spectrum Analyzer	10/31/14
ZATA91	HP (11713A)	Switch Driver	Verify Before Each Use
ZPS006	HP (6269B)	Power Supply	Verify Before Each Use
CTO037	ETS Lindgren (93686-8)	Current Clamp	5/31/14

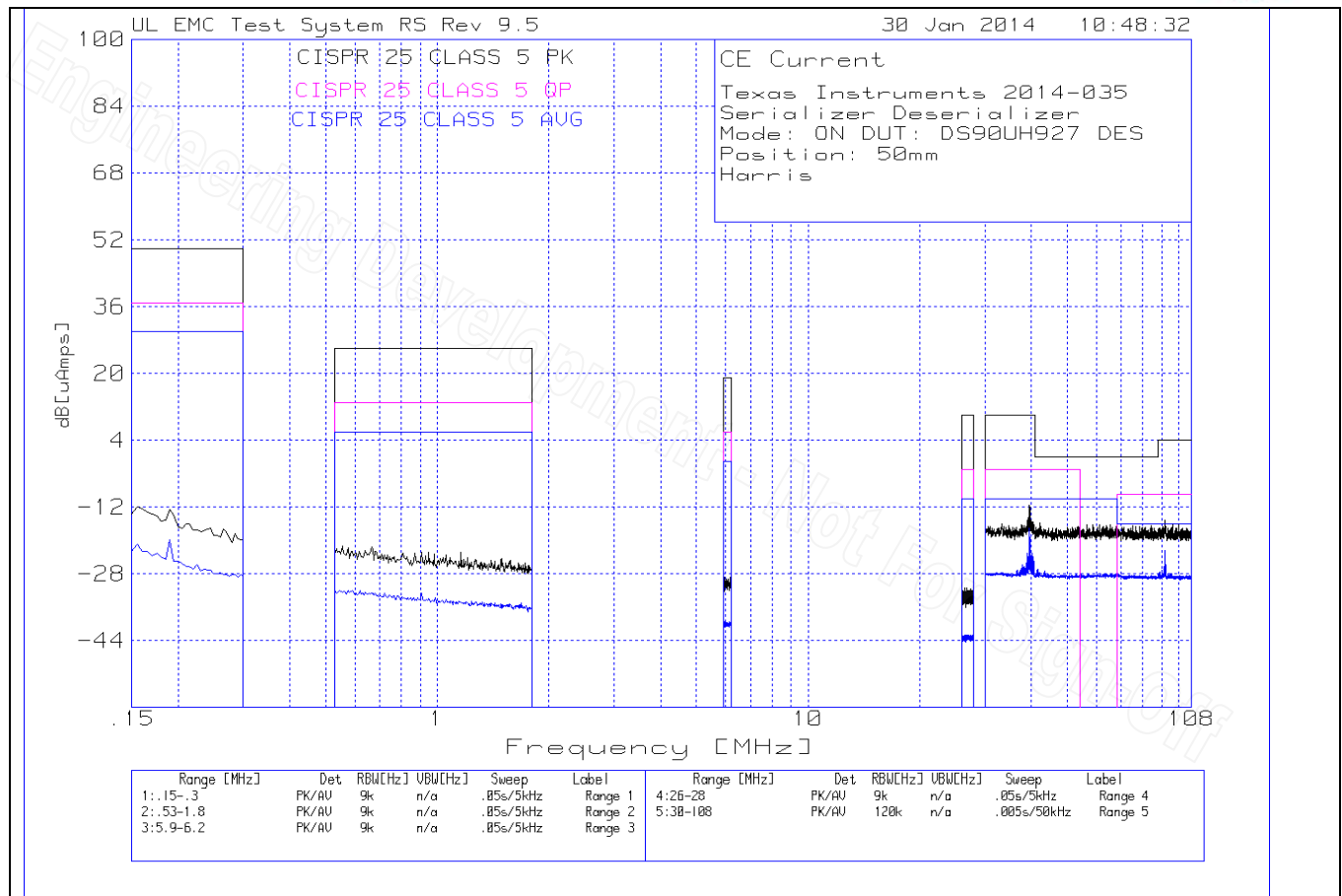


## Plots & Tables

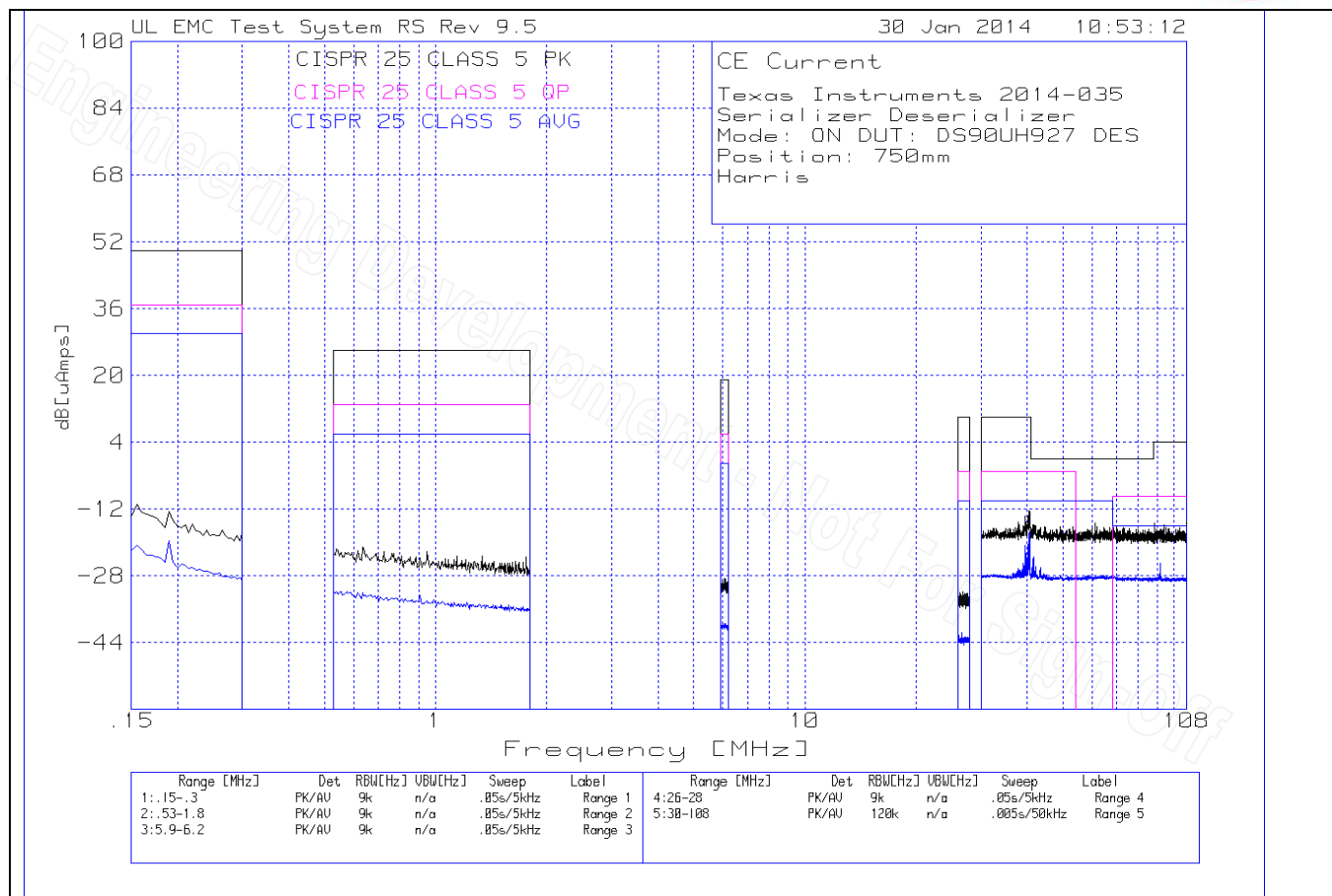




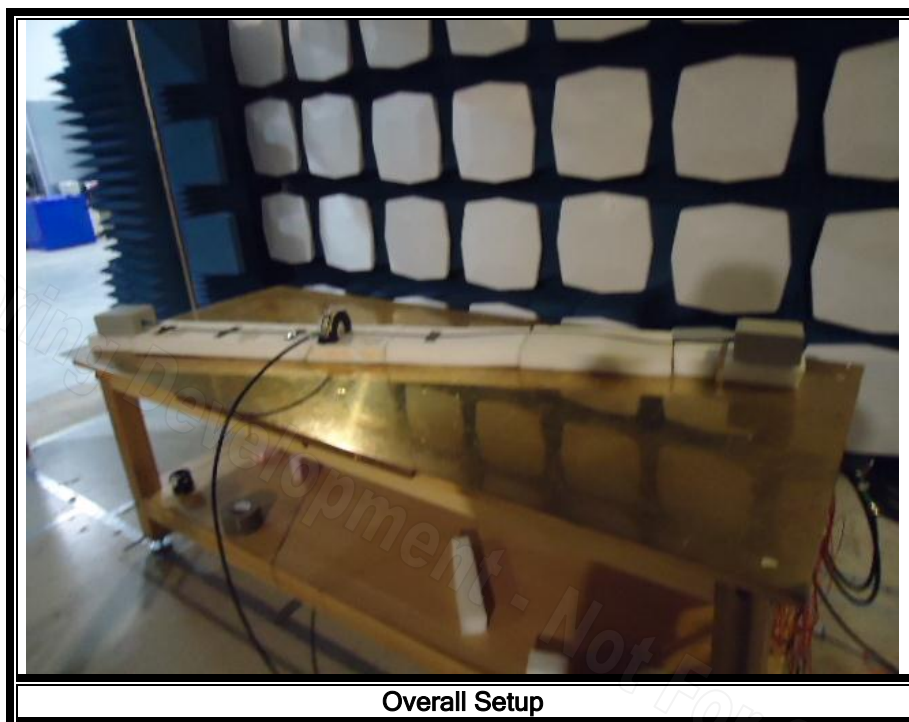
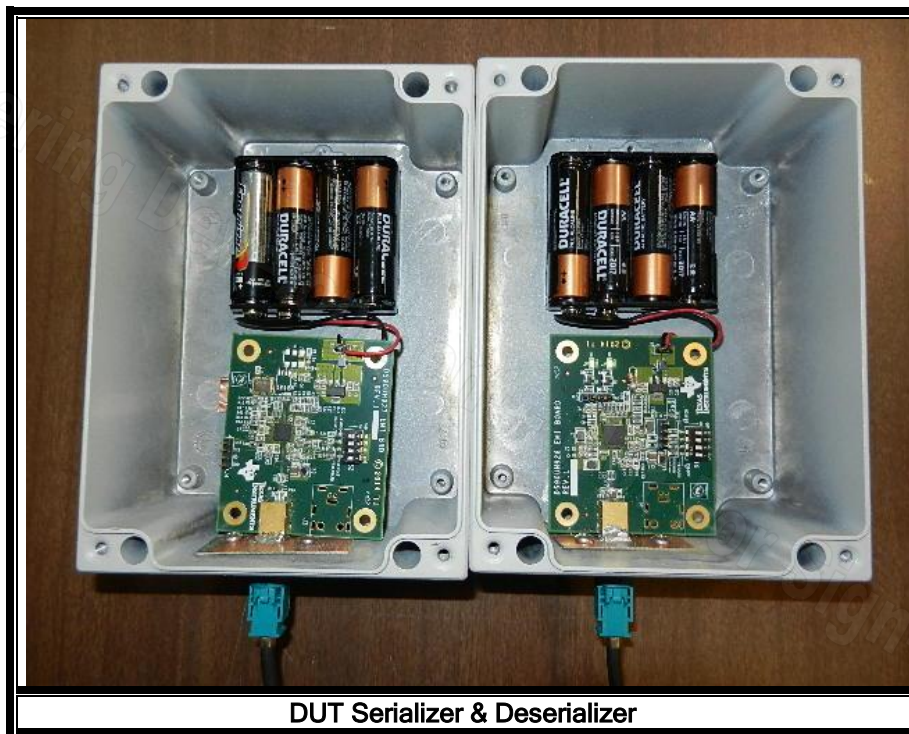


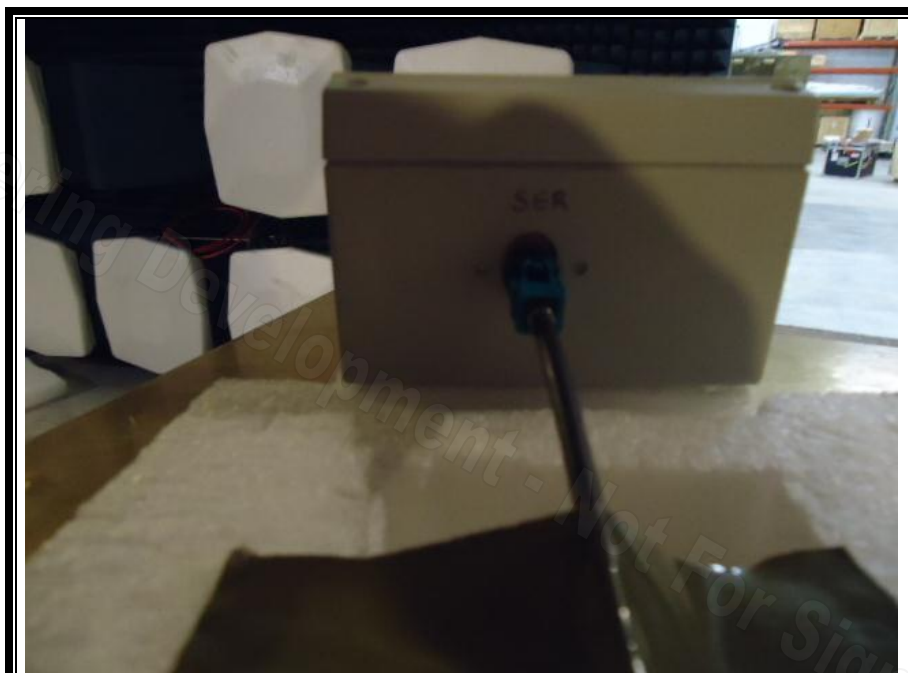






# PHOTOS

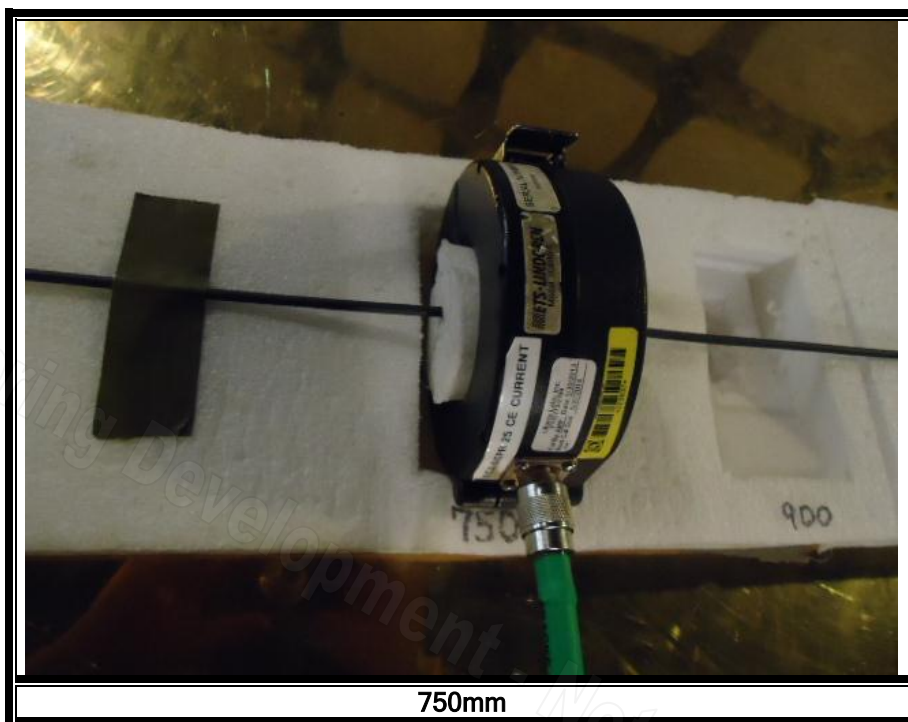
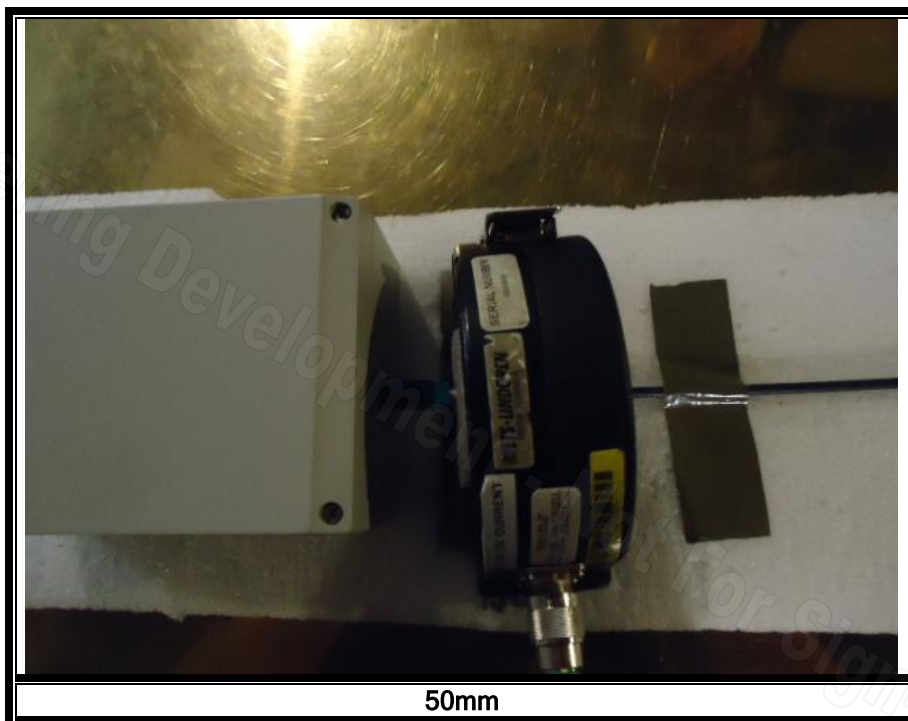




Serializer Connection to Harness



Deserializer Connection to Harness





**Test Method Name:** 6.4 Radiated Emissions - ALSE Method

**Report Author:** Victor Daugherty, NCT - WiSE Senior Engineer

**Test Setup Comments:** Testing was performed in accordance with the applicable specification and customer Instruction (no customer test plan). Note, Horn Testing not performed per customer instruction.

**DUT Disposition:** Devices were retained in the UL EMC Lab for subsequent testing.

**Summary of Results:** No peaks over the Class 5 limits





<b>Company Name:</b>	Texas Instruments	<b>Test Name:</b>	6.4 Radiated Emissions - ALSE Method
<b>Harness Information:</b>	2.0 m	<b>Date(s) test performed:</b>	1/29/2014
<b>Grounding Information:</b>	Remote Ground	<b>Temperature (°C):</b>	21
<b>Pretest inspection:</b>	<input checked="" type="checkbox"/> No anomalies <input type="checkbox"/> The following anomalies:	<b>Humidity (%RH):</b>	28
<b>Post test inspection:</b>	<input checked="" type="checkbox"/> No anomalies <input type="checkbox"/> The following anomalies:	<b>Tested by:</b>	Victor Daugherty, NCT
		<b>Software Version:</b>	UL EMC 9.5
<b>Sample #</b>	DS90UH927 (SER)/ DS90UH928 (DES)		
<b>Mode:</b>	On		
<b>Ambient Compliant</b>	<input checked="" type="checkbox"/> Rod / <input checked="" type="checkbox"/> V Bic / <input checked="" type="checkbox"/> H Bic / <input checked="" type="checkbox"/> V Log / <input checked="" type="checkbox"/> H Log		
<b>Antenna Type</b>	<b>Comments</b>	<b>Over/Under Limit</b>	
Rod		<input type="checkbox"/> Over <input checked="" type="checkbox"/> Under	
Bicon Vertical		<input type="checkbox"/> Over <input checked="" type="checkbox"/> Under	
Bicon Horizontal		<input type="checkbox"/> Over <input checked="" type="checkbox"/> Under	
Log Vertical		<input type="checkbox"/> Over <input checked="" type="checkbox"/> Under	
Log Horizontal		<input type="checkbox"/> Over <input checked="" type="checkbox"/> Under	

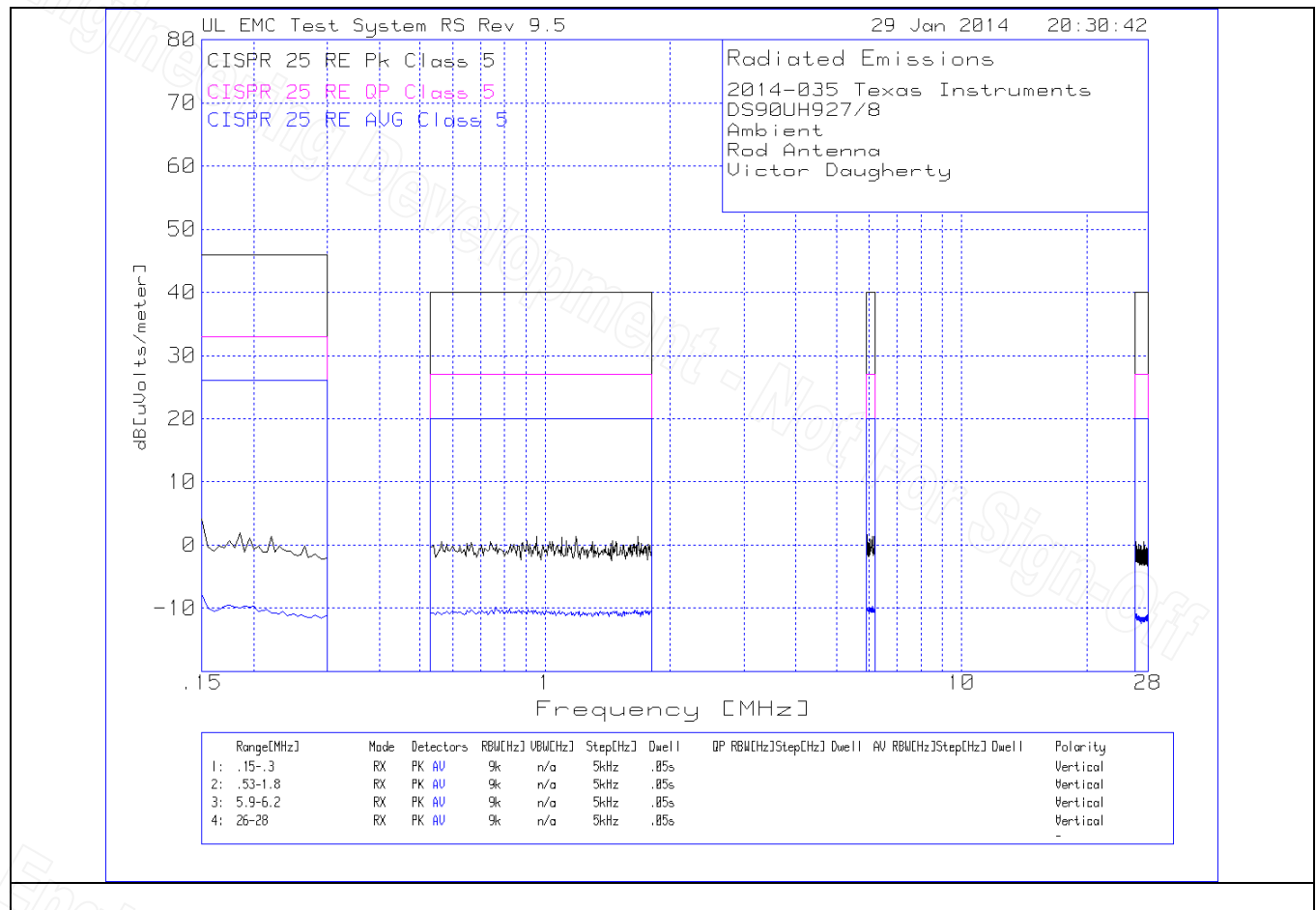


### UL Provided Test Equipment

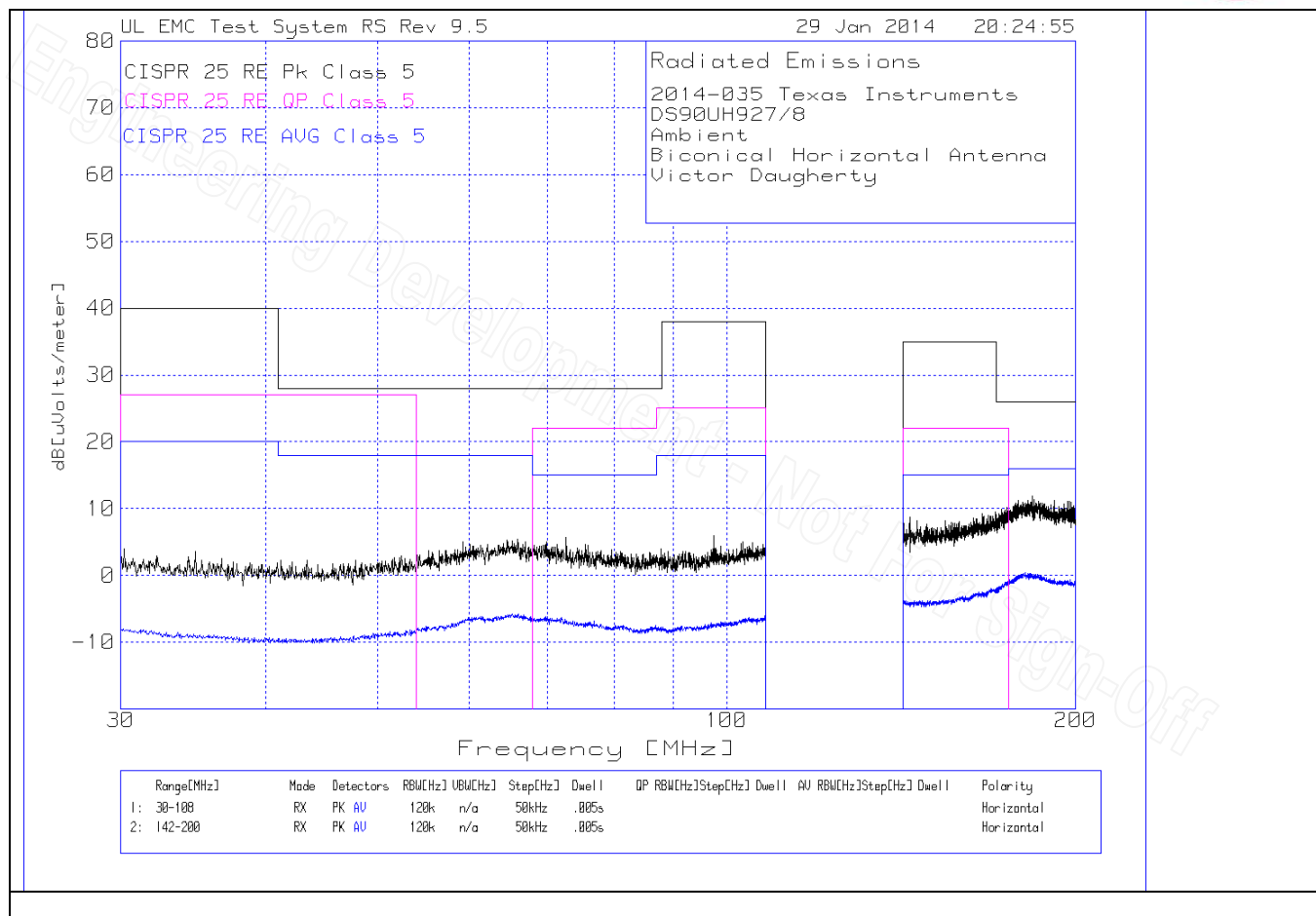
Asset #	Manufacturer / Model #	Description	Cal. Due
ATA804	ETS Lindgren (-)	Chamber	1/31/15
SA0014	Rohde & Schwarz (ESCI7)	Spectrum Analyzer	10/31/14
AT0058	ETS Lindgren (3301B)	Rod Antenna	9/28/14
AT0059	ETS Lindgren (3110C)	Bicon Antenna	6/31/14
AT0029	EMCO (3146)	Log Antenna	10/31/14
ATA406	Miteq (AM-1551-9625)	Bicon/Log Pre-amplifier/Path	11/31/15
ATA053	Solar (7333-5-TS-50-N)	LISN & 50 $\Omega$ Termination	1/31/15
ATA054	Solar (7333-5-TS-50-N)	LISN & 50 $\Omega$ Termination	1/31/15
ZATA91	HP (11713A)	Switch Driver	Verify Before Each Use
ZPS006	HP (6269B)	Power Supply	Verify Before Each Use

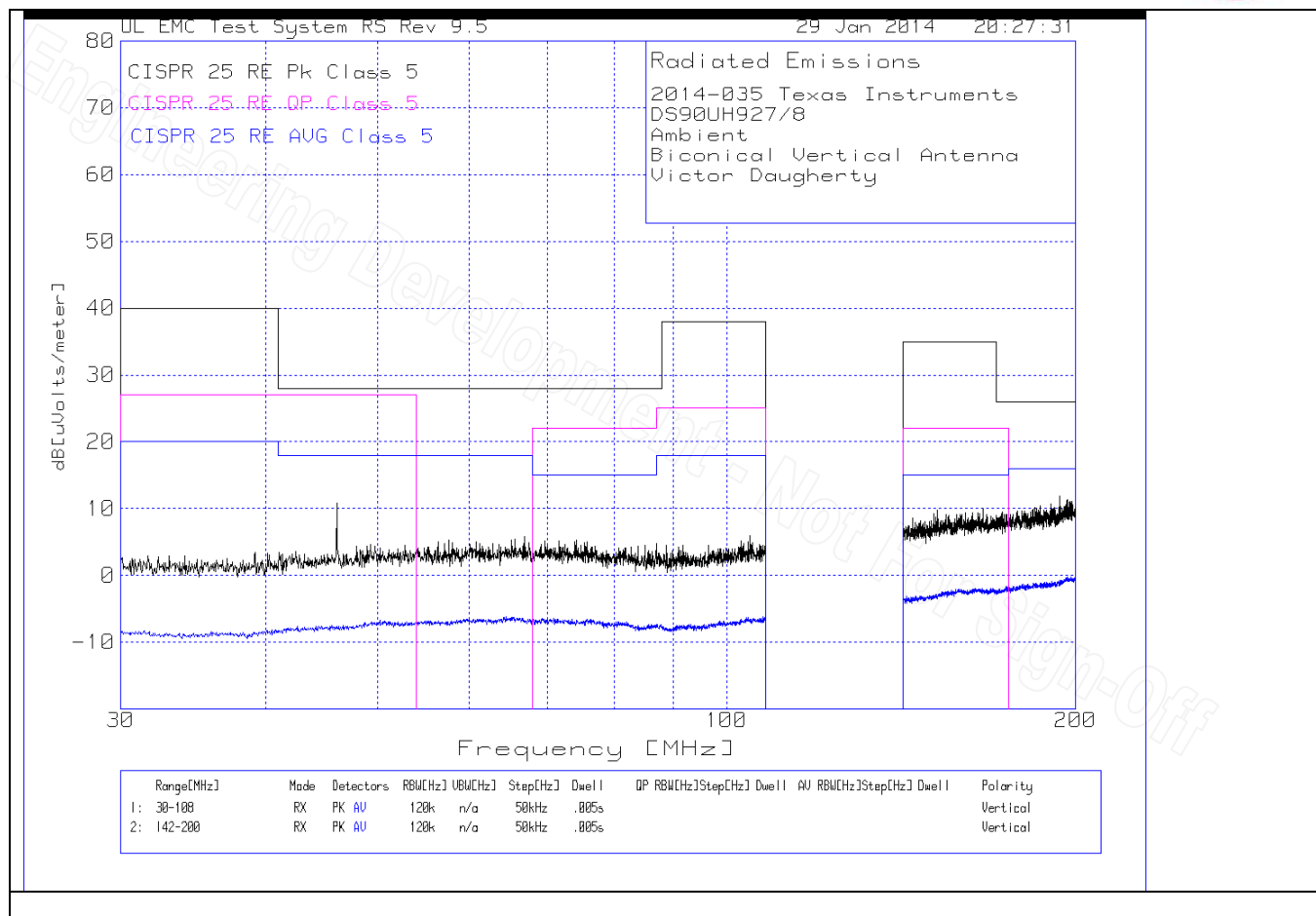


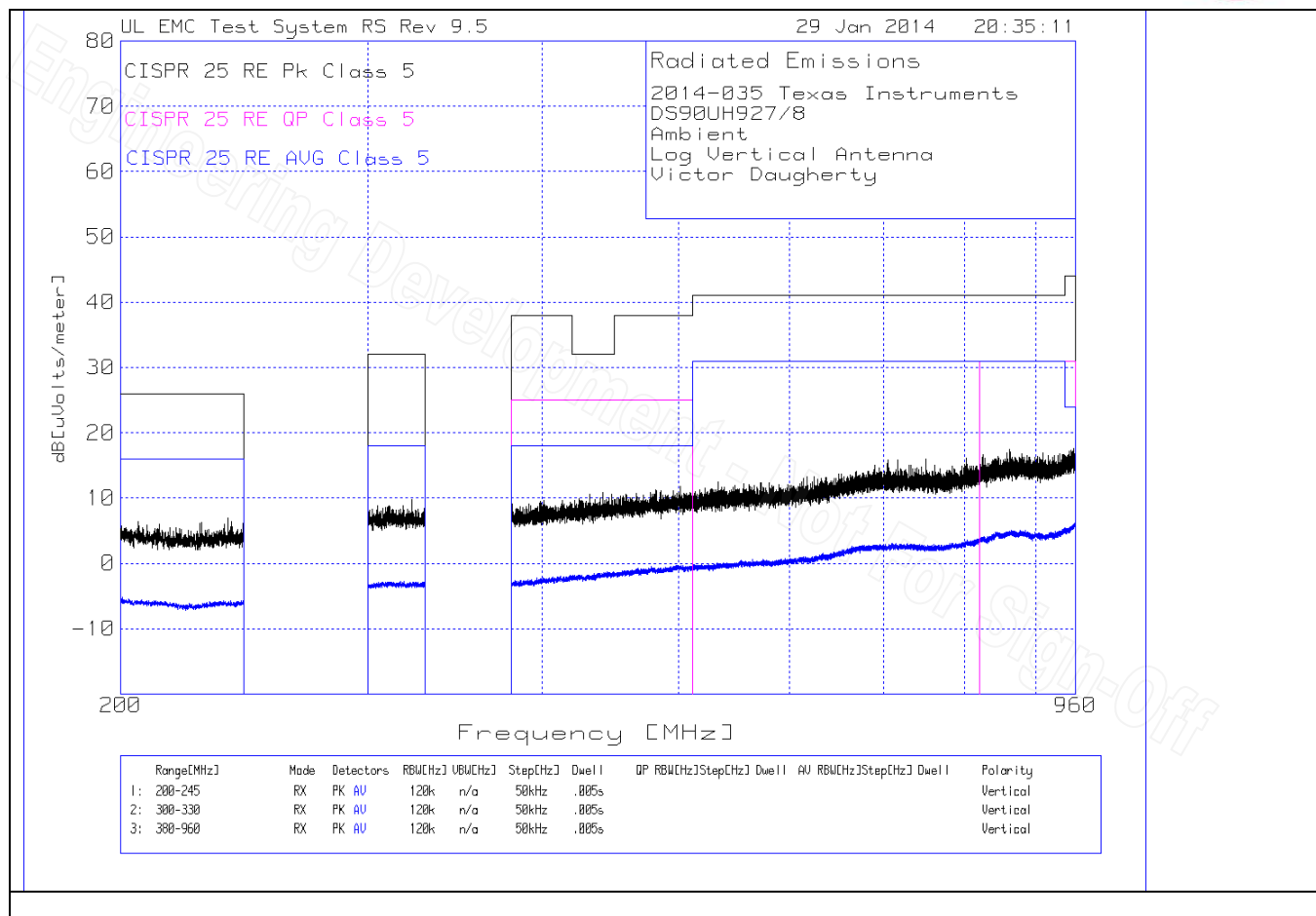
## Plots & Tables

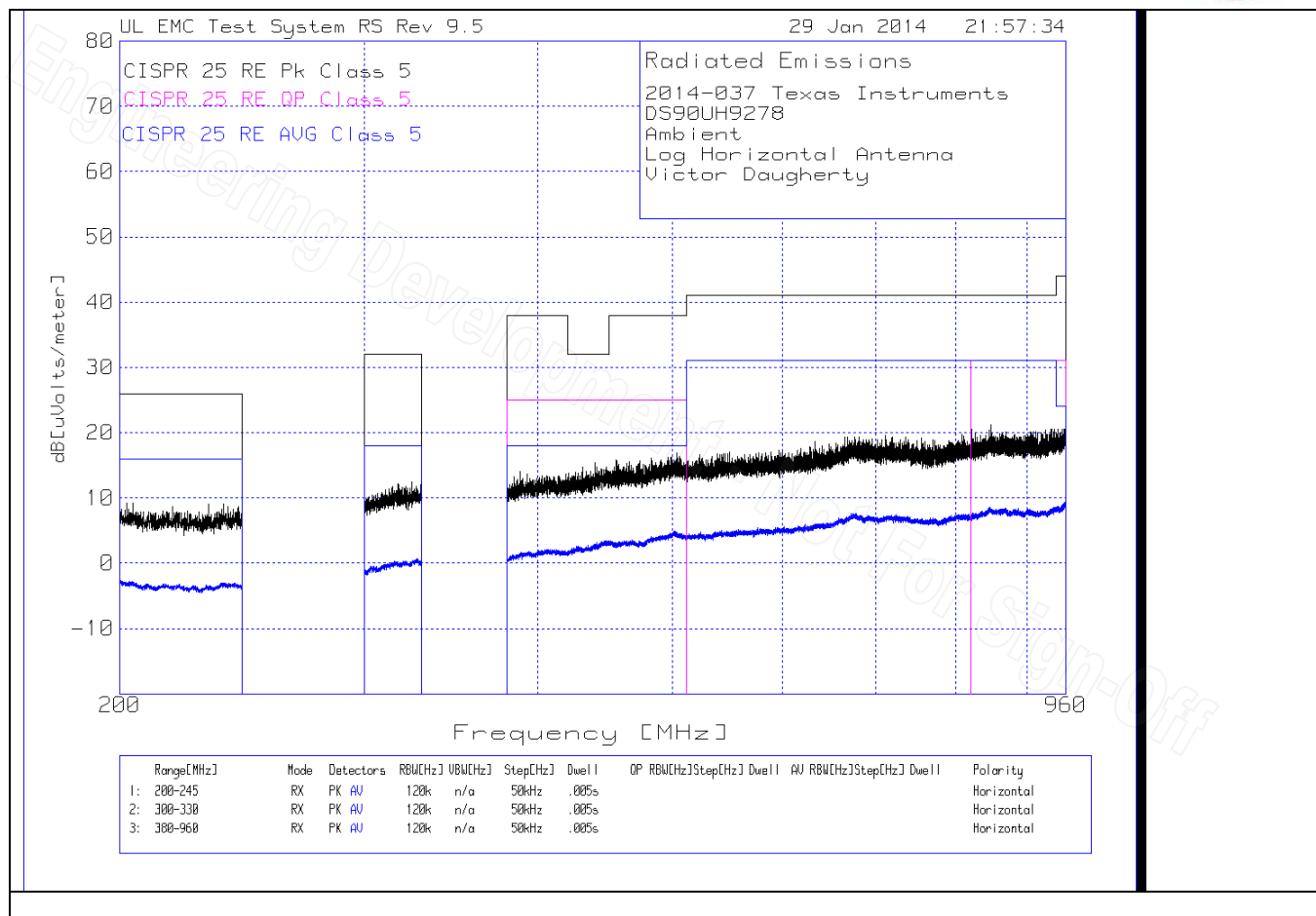


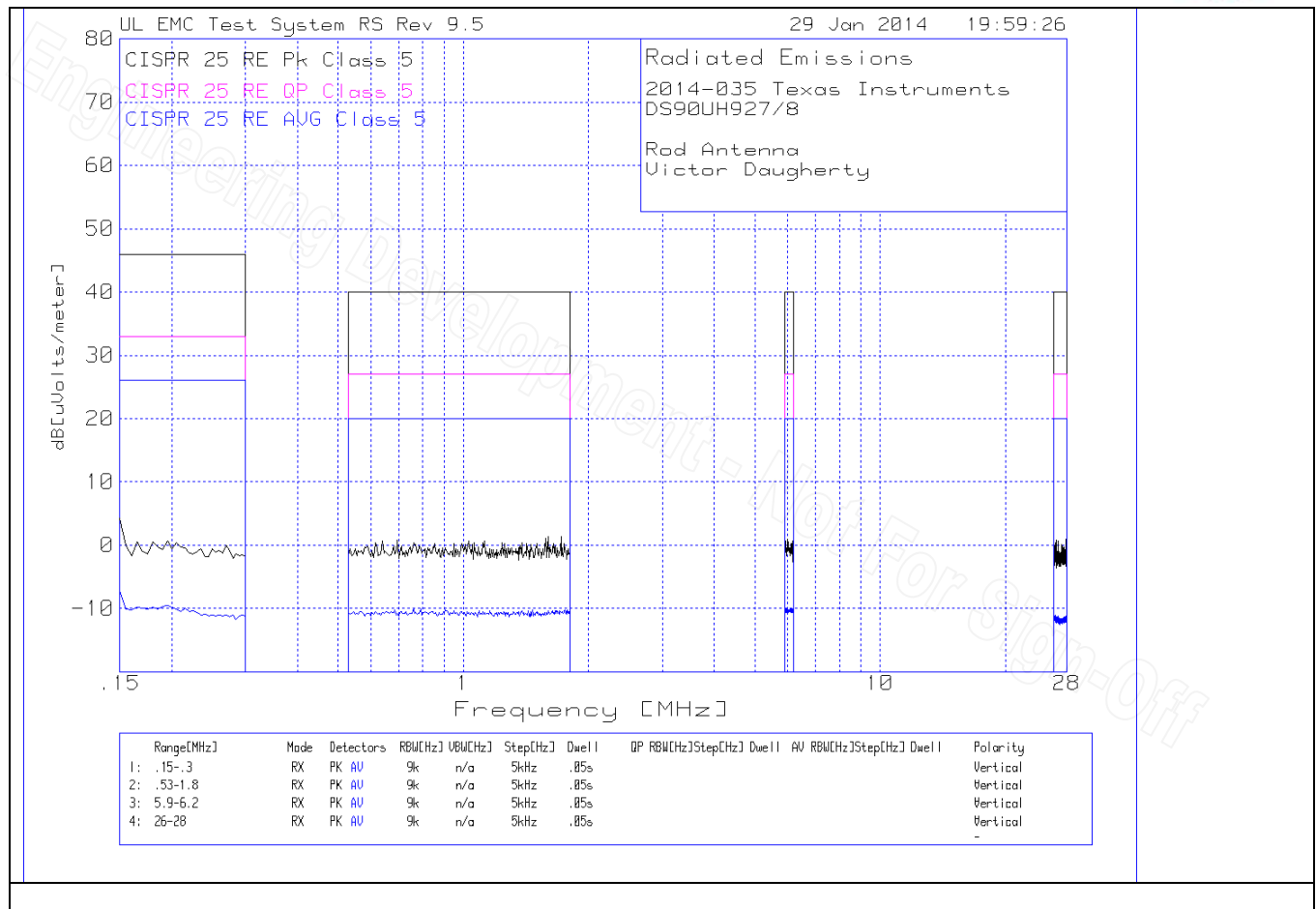


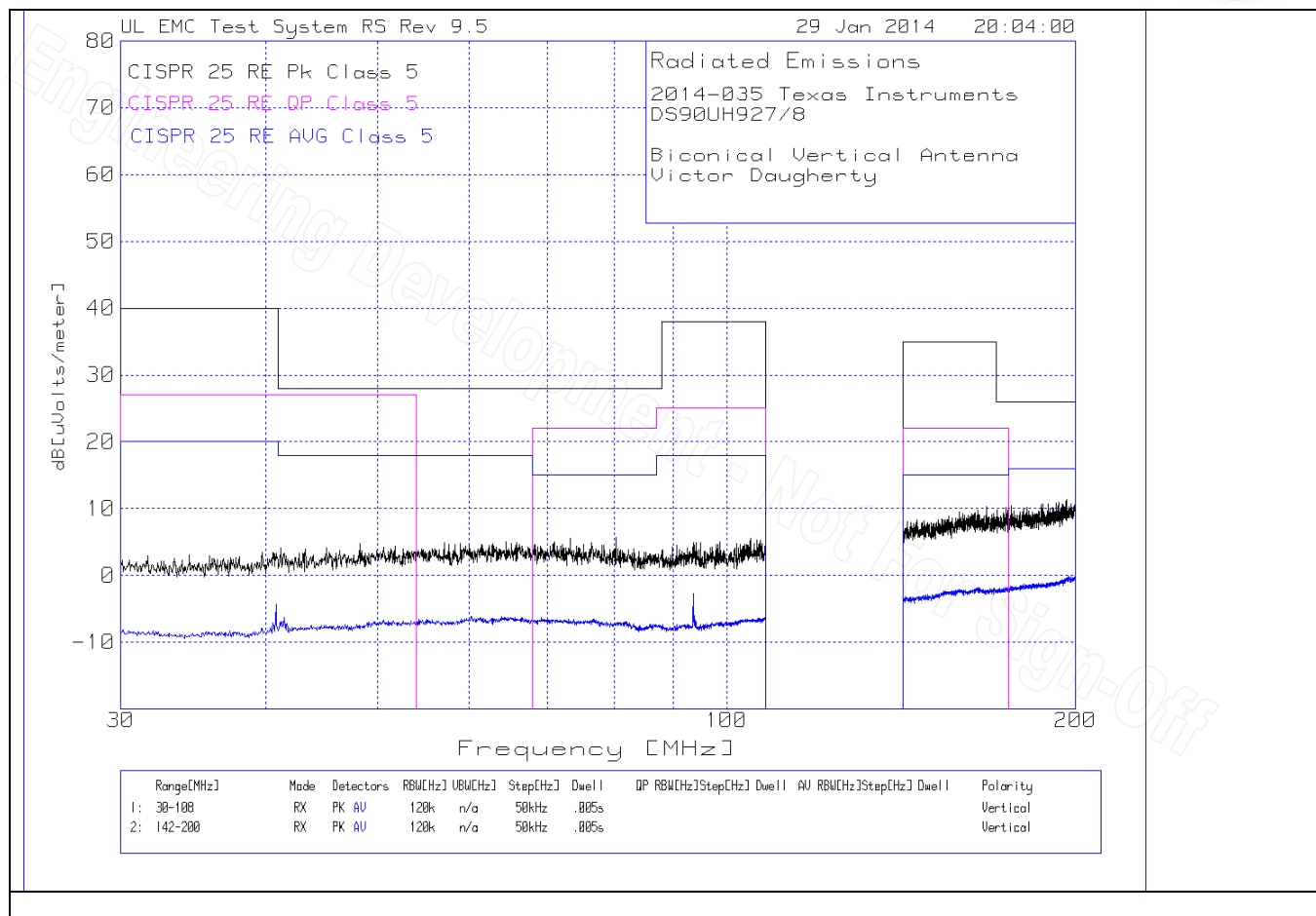


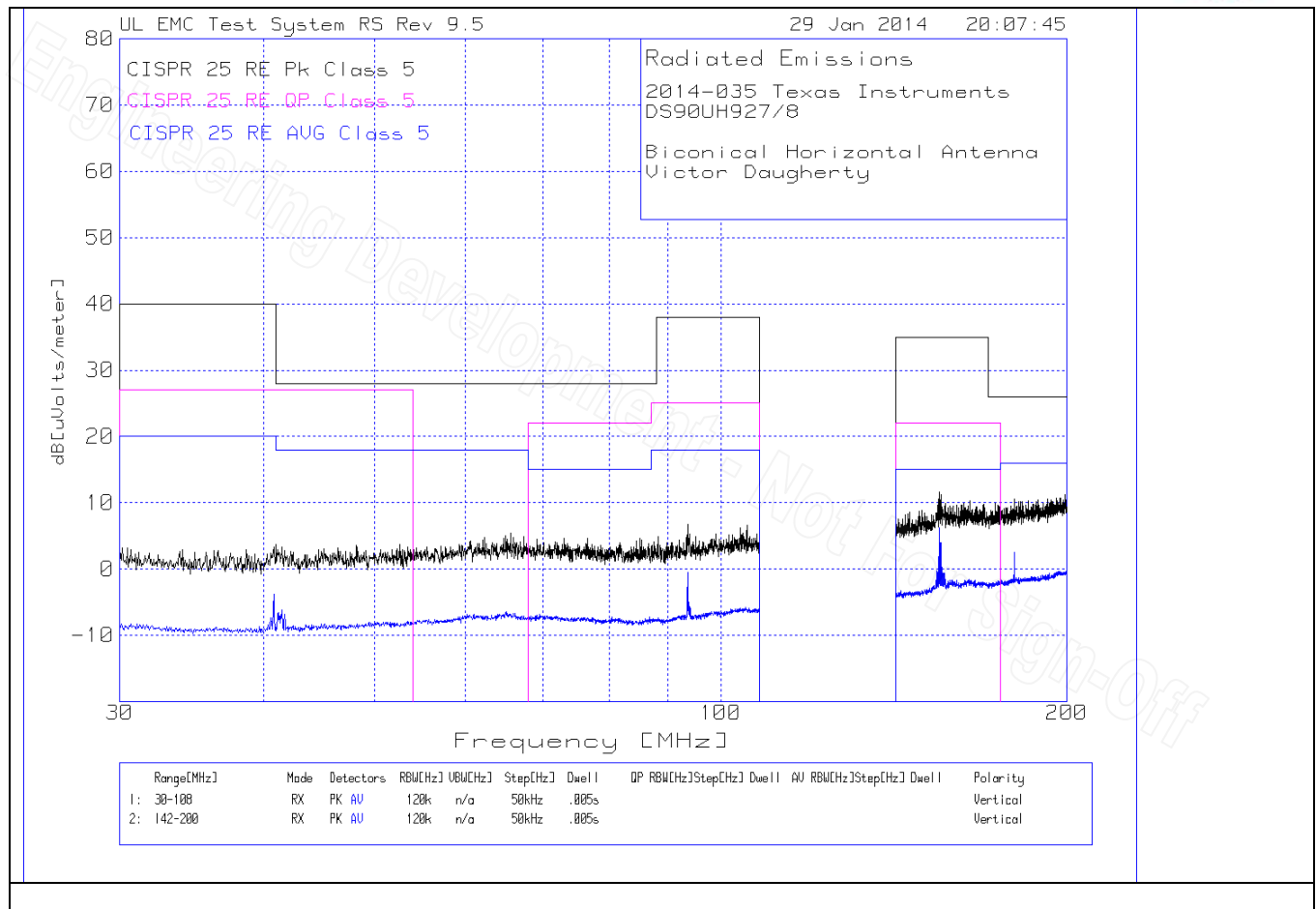


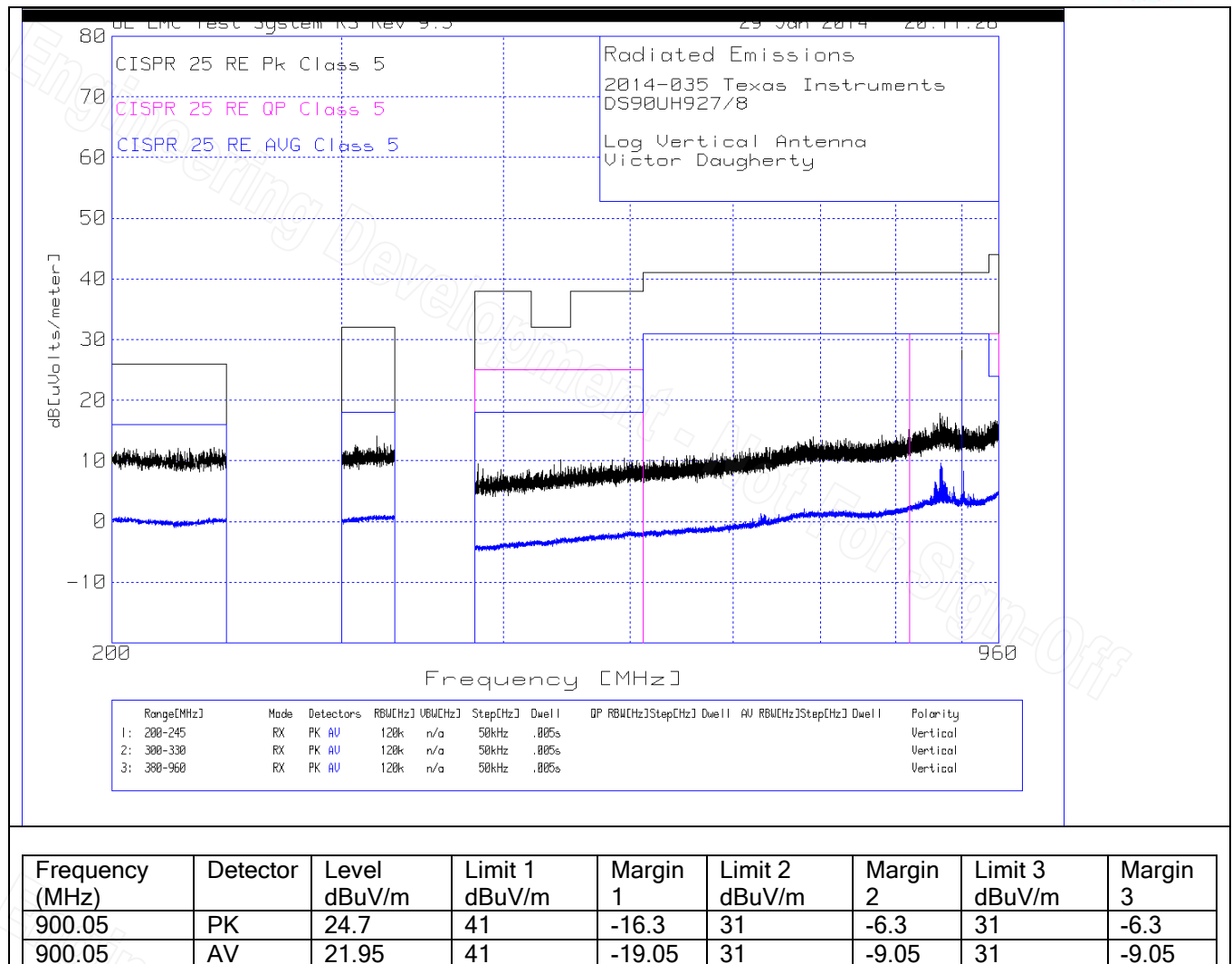




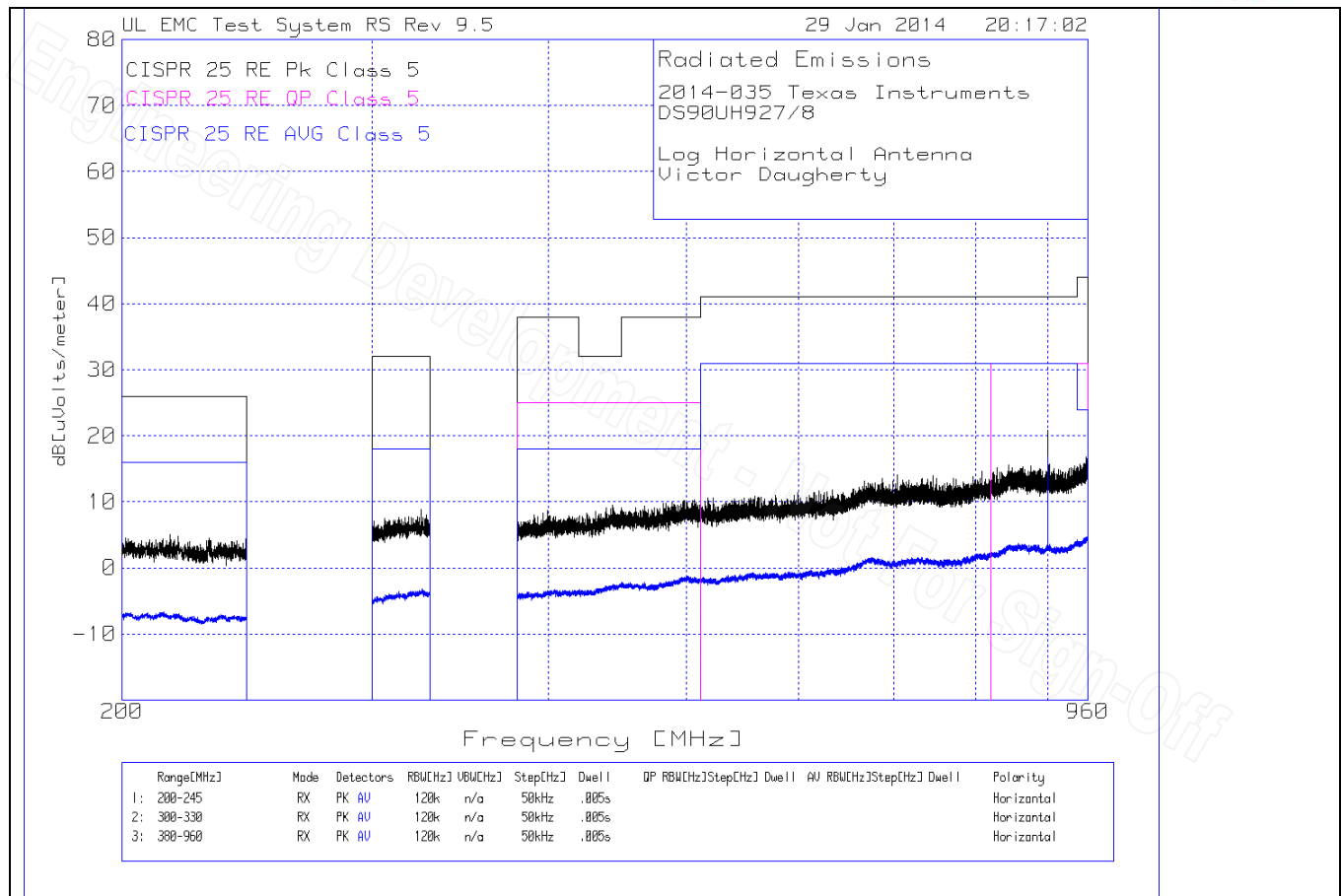






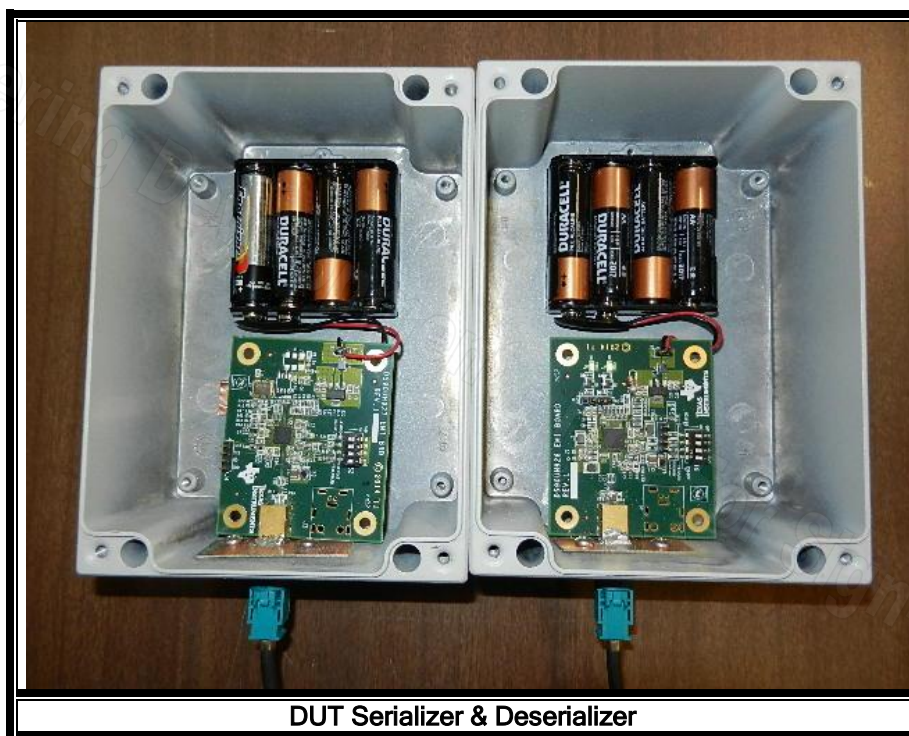








## PHOTOS



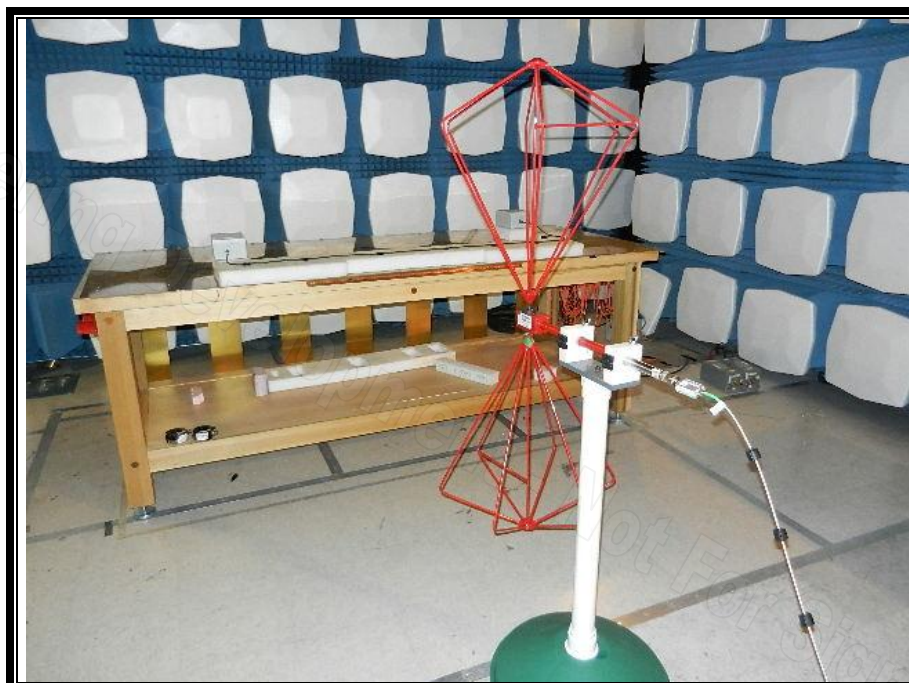


Rod Antenna setup

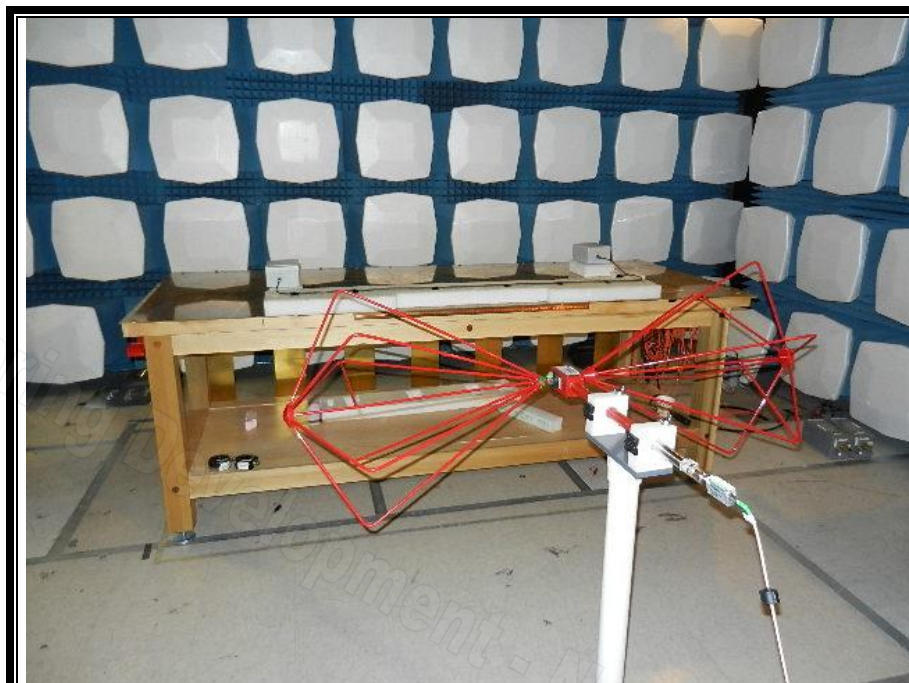


Deserializer setup

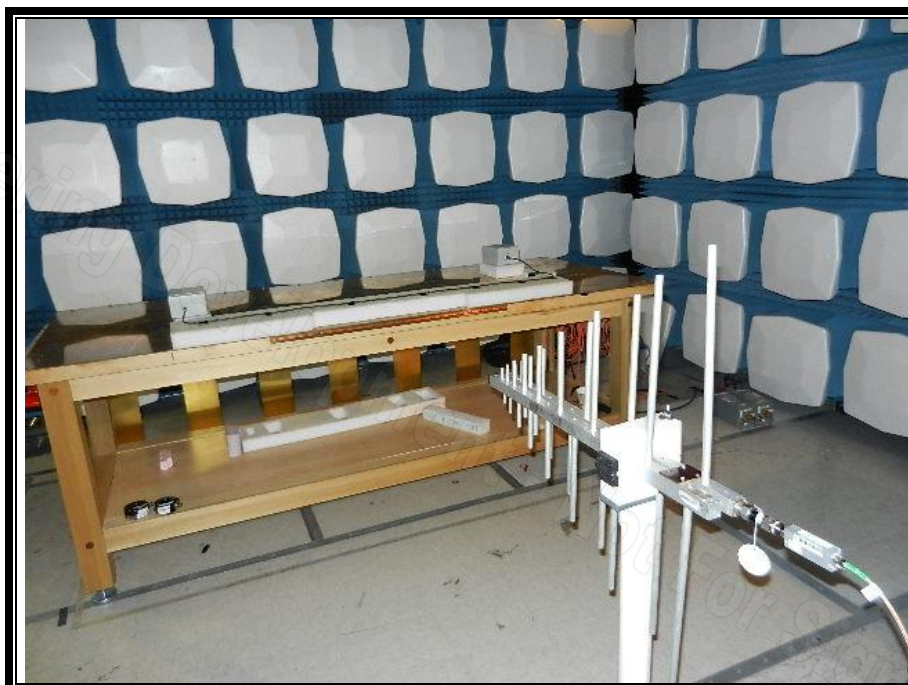




**Biconical Vertical setup**



**Biconical Horizontal setup**



Log Vertical setup



Log Horizontal setup



**Test Method Name:** 11452-4 Bulk Current Injection

**Report Author:** Jason Harris - WiSE Laboratory Technician

**Test Setup Comments:** Testing was performed in accordance with the applicable specification and customer Instruction (no customer test plan)/.

**Device Monitoring:** Customer performed Pre and Post functional only.

**DUT Disposition:** Devices were retained in the UL EMC Lab for subsequent testing.

**Summary of Results:** No anomalies noted during testing.



<b>Company Name:</b>	Texas Instruments	<b>Test Name:</b>	11452-4 Bulk Current Injectio
<b>Harness Information:</b>	2.0 m	<b>Date(s) test performed:</b>	1/30/2014
<b>Grounding Information:</b>	Remote Ground	<b>Temperature (°C):</b>	21
<b>Frequency Range:</b>	1-400MHz	<b>Humidity (%RH):</b>	14
<b>Dwell Time (Seconds):</b>	2	<b>Tested by:</b>	Jason Harris
<b>Modulation:</b>	CW and AM	<b>Software Version:</b>	BCI 2.5
<b>Sample #</b>	DS90UH927 (SER)	<b>Pretest inspection:</b>	<input checked="" type="checkbox"/> No anomalies <input type="checkbox"/> The following anomalies:
<b>Mode:</b>	On	<b>Post test inspection:</b>	<input checked="" type="checkbox"/> No anomalies <input type="checkbox"/> The following anomalies:
<b>Position (mm)</b>	<b>Frequency (MHz)</b>	<b>Level (mA)</b>	<b>DUT Performance</b>
<input checked="" type="checkbox"/> 150 CBCI	<input checked="" type="checkbox"/> CW (1-400) <input checked="" type="checkbox"/> AM	200	1
<input checked="" type="checkbox"/> 450 CBCI	<input checked="" type="checkbox"/> CW (1-400) <input checked="" type="checkbox"/> AM	200	1
<input checked="" type="checkbox"/> 750 CBCI	<input checked="" type="checkbox"/> CW (1-400) <input checked="" type="checkbox"/> AM	200	1

1 - No anomalies





<b>Company Name:</b>	Texas Instruments	<b>Test Name:</b>	11452-4 Bulk Current Injectio
<b>Harness Information:</b>	2.0 m	<b>Date(s) test performed:</b>	1/30/2014
<b>Grounding Information:</b>	Remote Ground	<b>Temperature (°C):</b>	21
<b>Frequency Range:</b>	1-400MHz	<b>Humidity (%RH):</b>	14
<b>Dwell Time (Seconds):</b>	2	<b>Tested by:</b>	Jason Harris
<b>Modulation:</b>	CW and AM	<b>Software Version:</b>	BCI 2.5
<b>Sample #</b>	DS90UH928 (DESER)	<i>Pretest inspection:</i>	<input checked="" type="checkbox"/> No anomalies <input type="checkbox"/> The following anomalies:
<b>Mode:</b>	On	<i>Posttest inspection:</i>	<input checked="" type="checkbox"/> No anomalies <input type="checkbox"/> The following anomalies:
<b>Position (mm)</b>	<b>Frequency (MHz)</b>	<b>Level (mA)</b>	<b>DUT Performance</b>
<input checked="" type="checkbox"/> 150 CBCI	<input checked="" type="checkbox"/> CW (1-400) <input checked="" type="checkbox"/> AM	200	1
<input checked="" type="checkbox"/> 450 CBCI	<input checked="" type="checkbox"/> CW (1-400) <input checked="" type="checkbox"/> AM	200	1
<input checked="" type="checkbox"/> 750 CBCI	<input checked="" type="checkbox"/> CW (1-400) <input checked="" type="checkbox"/> AM	200	1

1 - No anomalies



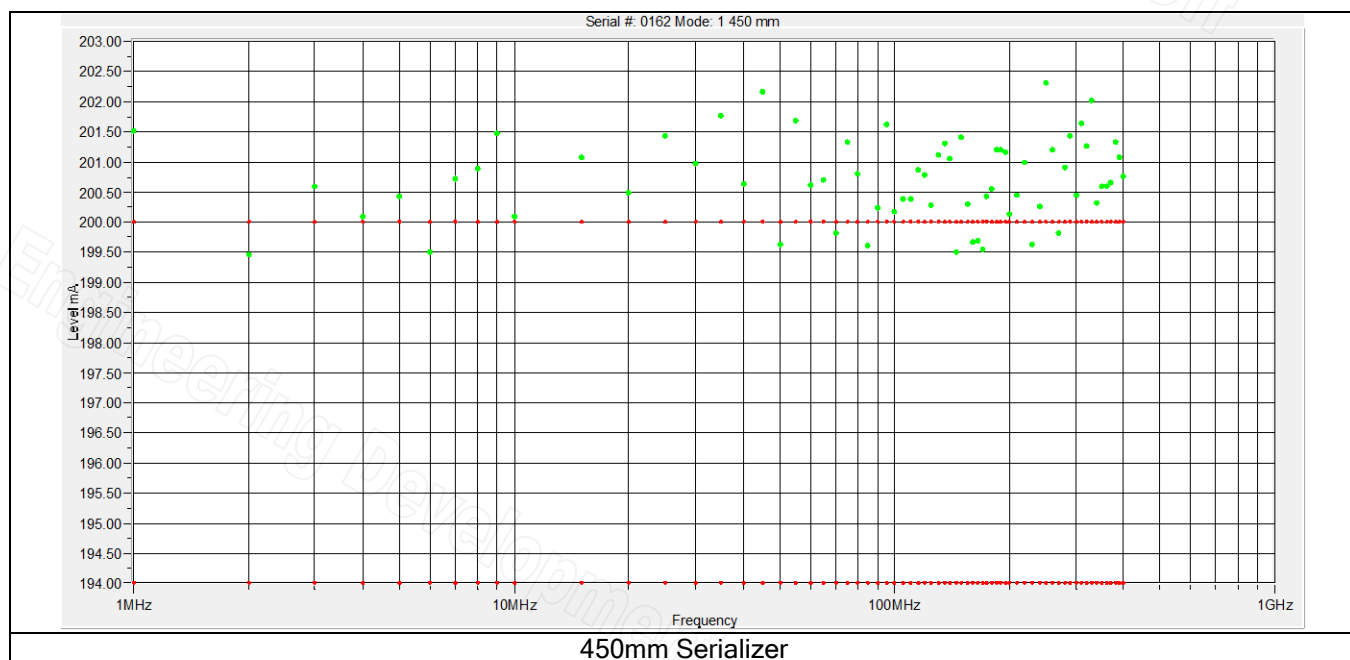
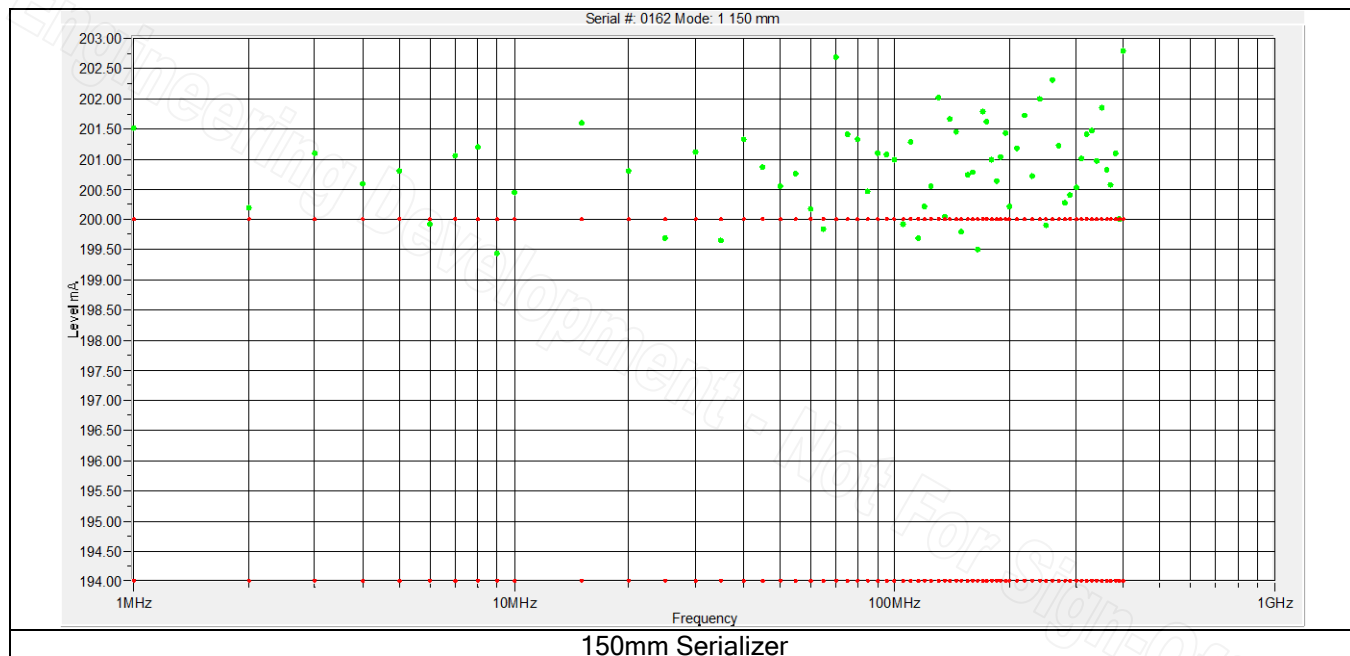


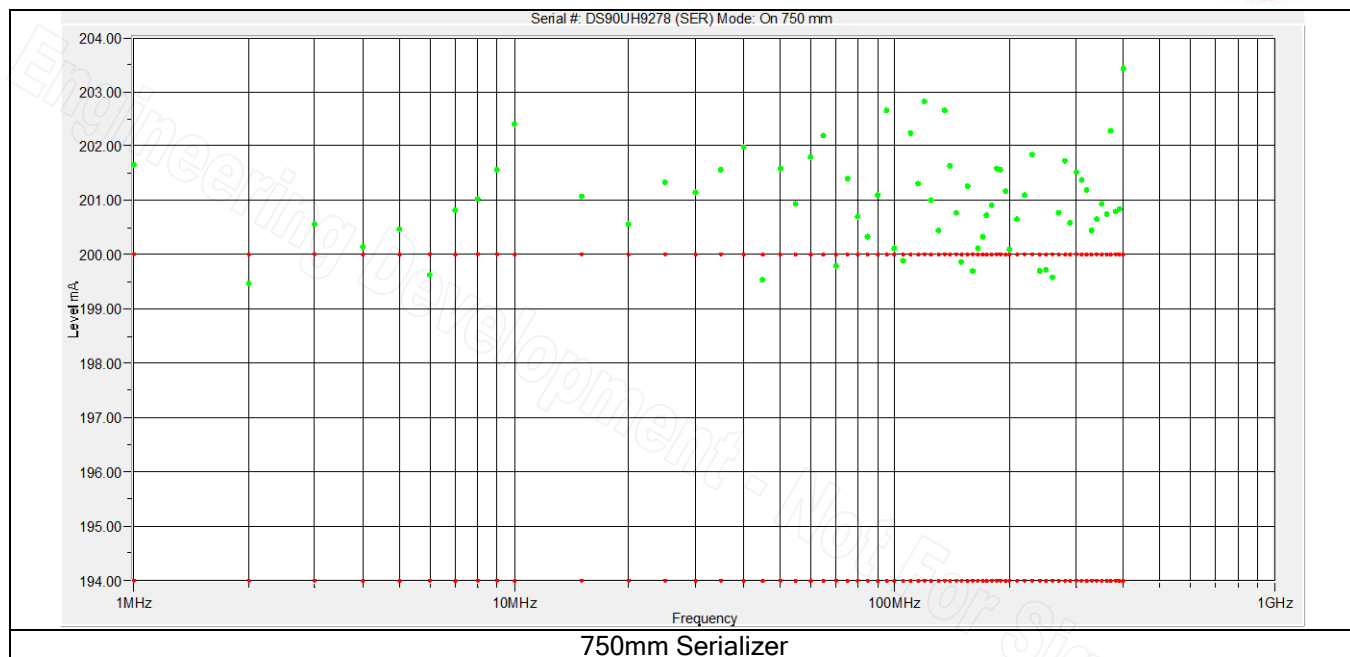
#### UL Provided Test Equipment

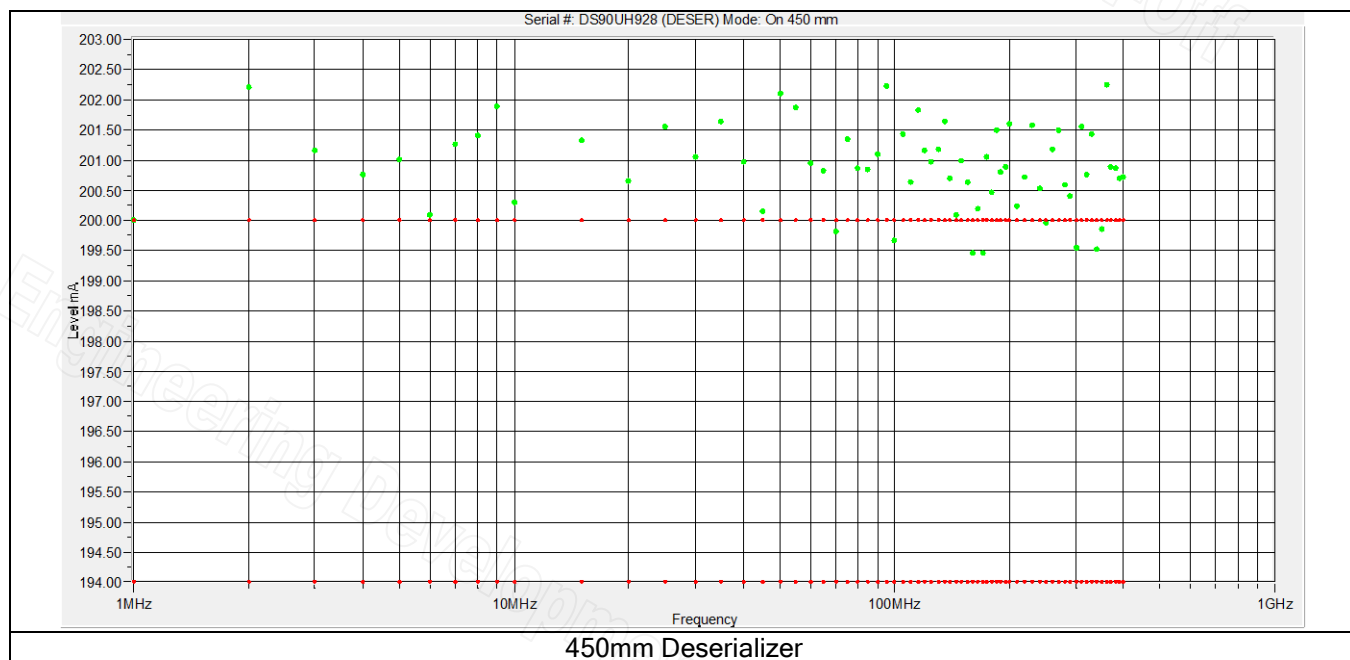
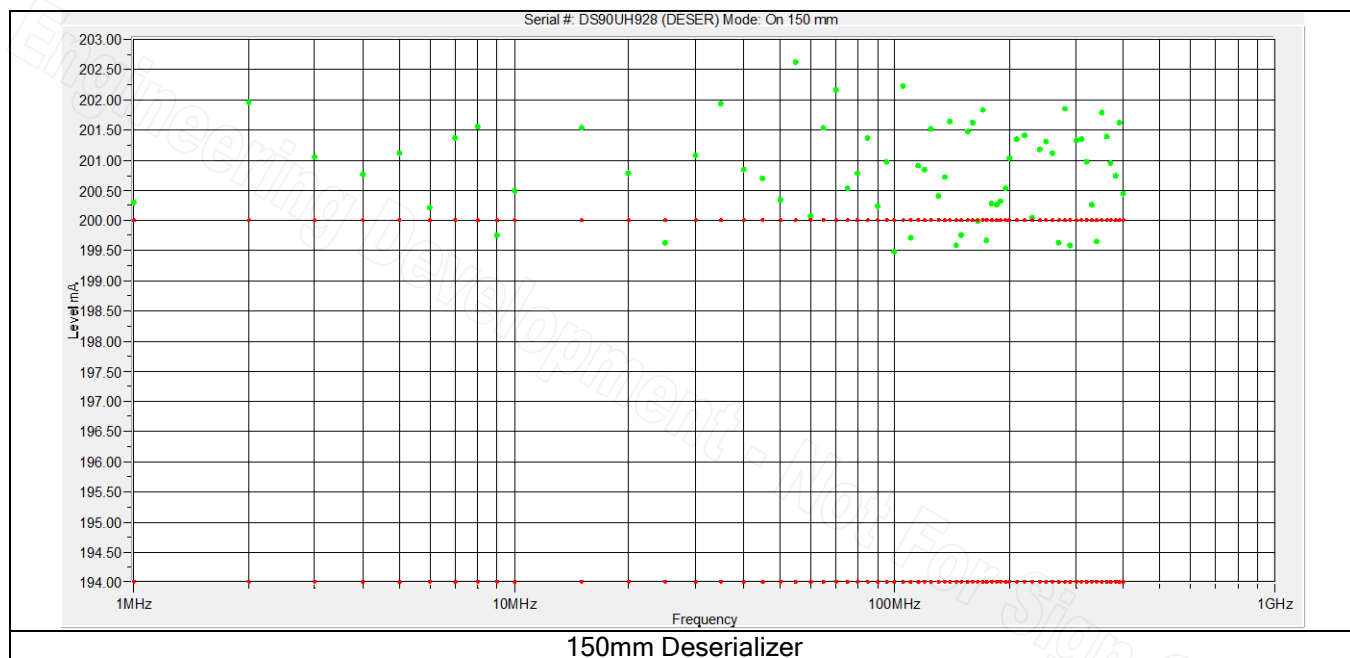
Asset #	Manufacturer / Model #	Description	Cal. Due
ATA801	Chamber ( - )	BCI #1A Chamber	1/31/15
ZCT014	Fischer Custom Communications (F140)	Current Injection Probe (100 kHz - 1000 MHz)	Verified before use
ATA048	Fischer Custom Communications (FCC-BCICF-1)	Calibration Fixture (10kHz - 450MHz)	6/20/14
FG0015	Rhode & Schwarz (SMT02)	Signal Generator (5kHz - 1.5MHz)	1/31/15
SA0005	Hewlett Packard (8591E)	Spectrum Analyzer	1/31/15
ZATA29	Amplifier Research (100W1000B)	Amplifier (1MHz - 1000MHz)	Verified before use
ATA119	Termaline (8166)	50 Ohm Termination	1/31/15
ATA043	Werlatone (C2630)	Directional Coupler (10kHz - 1000MHz)	1/31/15
ATA115	Amplifier Research (LA150)	Attenuator (40dB)	1/31/15
PAR014	Gigatronics (80301A)	Power Sensor	1/31/15
PAR015	Gigatronics (80301A)	Power Sensor	1/31/15
PA0011	Gigatronics (8542C)	Power Meter	1/31/15

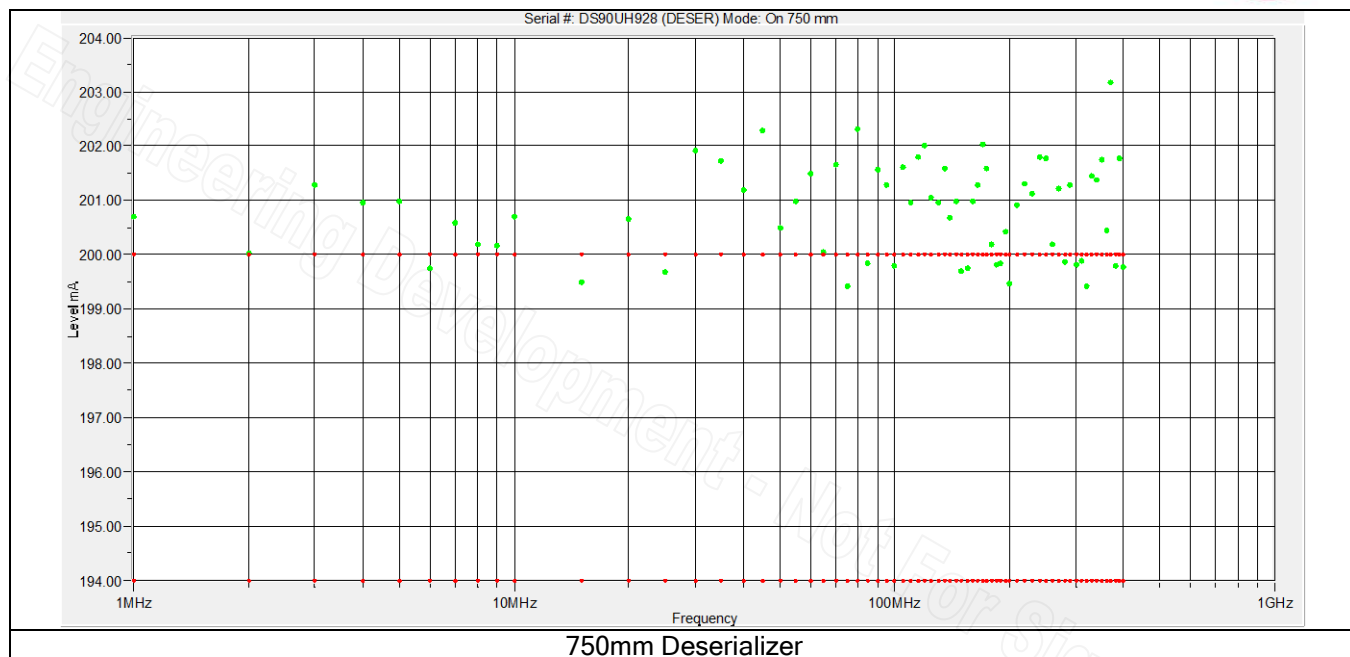


## Plots & Tables

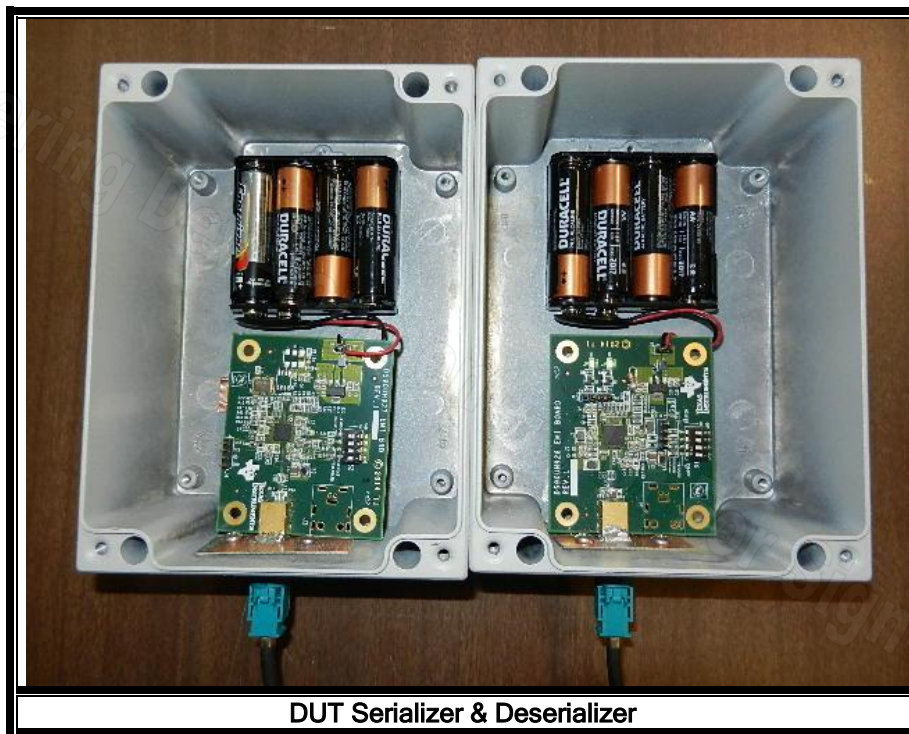




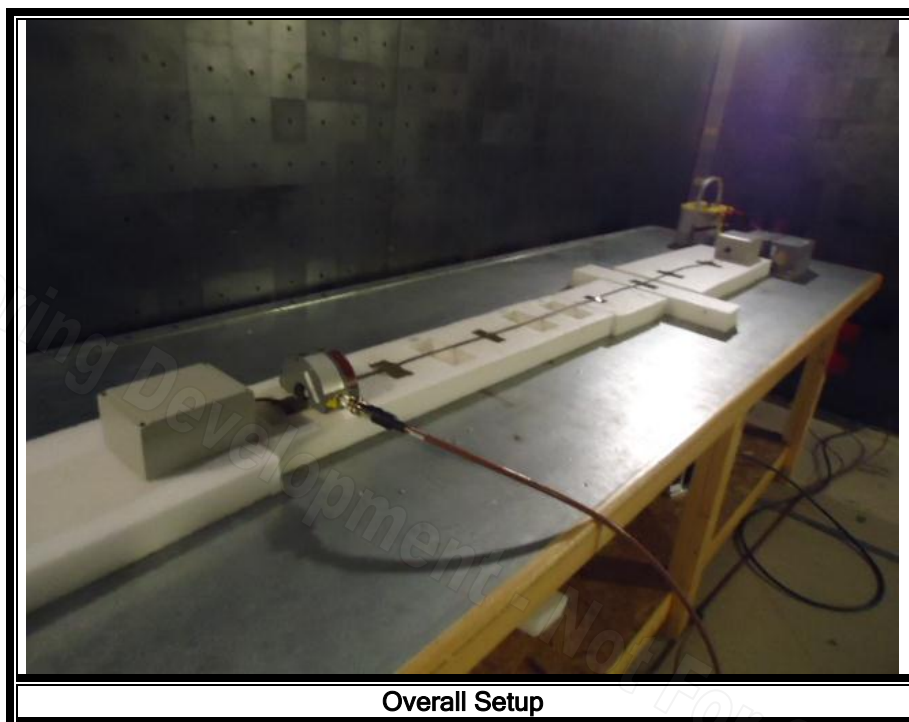




# PHOTOS



DUT Serializer & Deserializer



Overall Setup





